

N Channel MOSFET

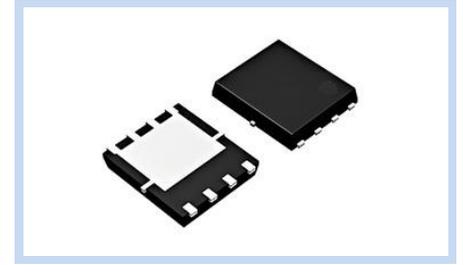
30V 105A DFN5×6-8L

MFT3N105D56

MERITEK

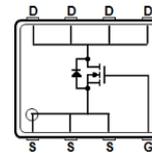
FEATURE

- RDS(ON)<2.8mΩ at VGS=10V
- RDS(ON)<4.8mΩ at VGS=4.5V
- Super High Dense Cell Design For Low RDS(ON).
- Fast Switching Speed
- Application: DC/DC Converter, Motor Control



MECHANICAL DATA

- Case: DFN5×6-8L, Molded Plastic
- Terminals: Solderable per MIL-STD-750, Method 2026

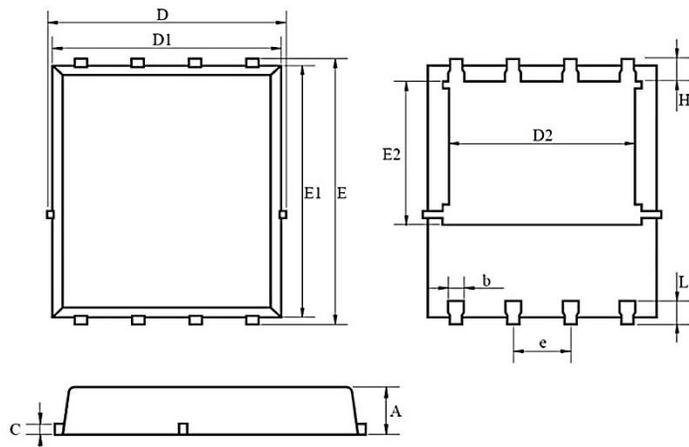


MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current – Continuous	I_D	$T_C=25^\circ\text{C}$	105
		$T_C=100^\circ\text{C}$	70
Drain Current – Pulsed	I_{DM}	420	A
Power Dissipation	P_D	60	W
Single Pulse Avalanche Energy	E_{AS}	441	mJ
Thermal Resistance Junction to Case	$R_{\theta JC}$	2.1	$^\circ\text{C/W}$
Operating Junction and Storage Temperature Range	T_J, T_{STG}	55 to +150	$^\circ\text{C}$

DIMENSIONS

Item	Min. (mm)	Max. (mm)
A	0.900	1.000
b	0.350	0.450
c	0.254 BSC	
D	4.944	5.096
D1	4.824	4.976
D2	3.910	4.110
E	5.974	6.126
E1	5.674	5.826
E2	3.375	3.575
e	1.270 BSC	
L	0.559	0.711
H	0.574	0.726



N Channel MOSFET

30V 105A DFN5×6-8L

MFT3N105D56

MERITEK

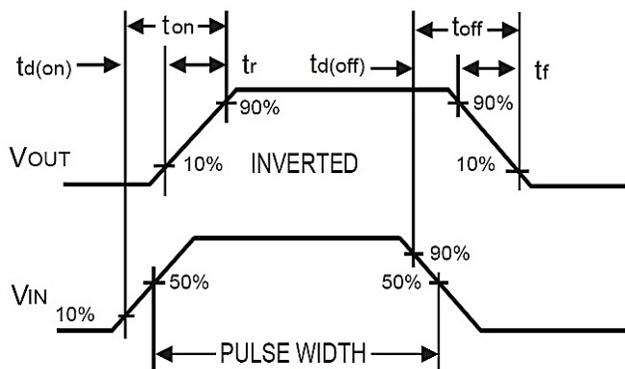
ELECTRICAL CHARACTERISTICS

Off Characteristics	Conditions	Symbol	Min	Typ.	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	BV_{DSS}	30	--	--	V
Drain-Source Leakage Current	$V_{DS}=24V, V_{GS}=0V$	I_{DSS}	--	--	1	μA
Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	I_{GSS}	--	--	± 100	nA
On Characteristics	Conditions	Symbol	Min	Typ.	Max	Unit
Static Drain-Source On-Resistance	$V_{GS}=10V, I_D=20A$	$R_{DS(ON)}$	--	2.2	2.8	m Ω
	$V_{GS}=4.5V, I_D=20A$		--	3.6	4.8	
Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	$V_{GS(th)}$	1.0	1.7	2.5	V
Dynamic Characteristics	Conditions	Symbol	Min	Typ.	Max	Unit
Total Gate Charge	$V_{DS}=15V, V_{GS}=10V, I_D=30A$	Q_g	--	75	--	nC
Gate-Source Charge		Q_{gs}	--	12	--	
Gate-Drain Charge		Q_{gd}	--	18.3	--	
Turn-On Delay Time	$V_{DS}=15V, V_{GS}=4.5V, R_G=1.8\Omega, I_D=60A$	$T_{d(on)}$	--	11	--	nS
Rise Time		T_r	--	20	--	
Turn-Off Delay Time		$T_{d(off)}$	--	60	--	
Fall Time		T_f	--	29	--	
Input Capacitance	$V_{DS}=25V, V_{GS}=0V, F=1MHz$	C_{iss}	--	3550	--	pF
Output Capacitance		C_{oss}	--	456	--	
Reverse Transfer Capacitance		C_{rss}	--	388	--	
Drain-Source Body Diode	Conditions	Symbol	Min	Typ.	Max	Unit
Diode Forward Current	--	I_S	--	--	105	A
Diode Forward Voltage	$V_{GS}=0V, I_S=1A, T_J=25^\circ C$	V_{SD}	--	--	1.2	V
Reverse Recovery Time	$I_F=20A, di/dt=100A/\mu s, T_J=25^\circ C$	T_{rr}	--	19	--	ns
Reverse Recovery Charge		Q_{rr}	--	7	--	nC

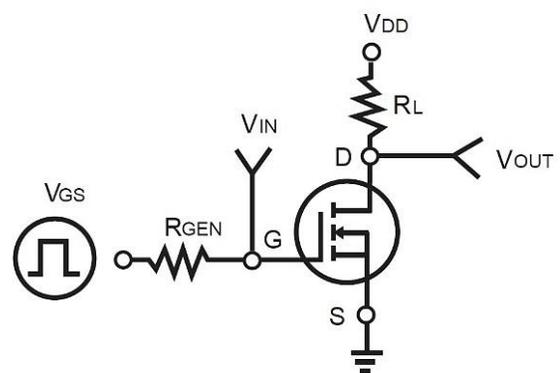
Note:

- $T_A=25^\circ C$, unless otherwise noted
- The E_{AS} test condition is $V_{DD}=20V, V_{GS}=10V, L=0.5mH, R_G=25\Omega$.

Switching Time Waveform



Switching Test Circuit



N Channel MOSFET

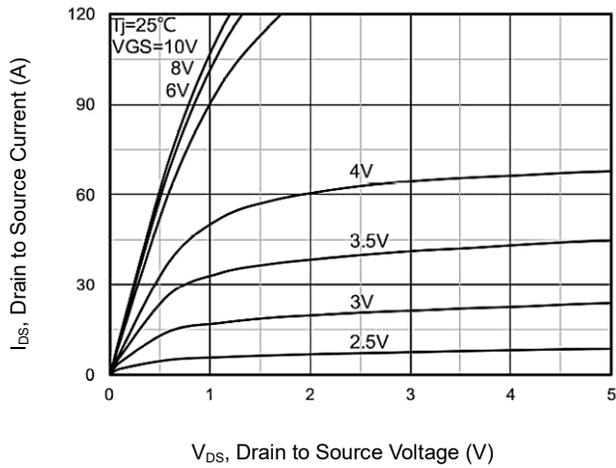
30V 105A DFN5×6-8L

MFT3N105D56

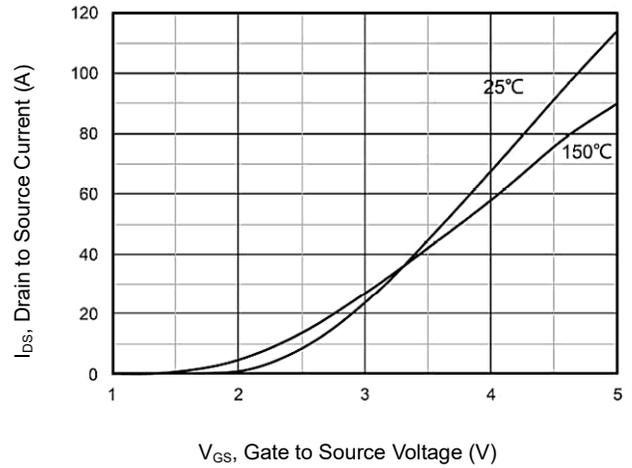
MERITEK

CHARACTERISTIC CURVES

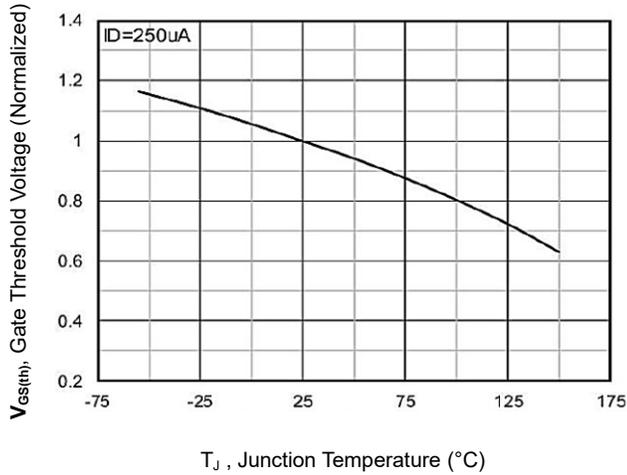
On-Region Characteristics



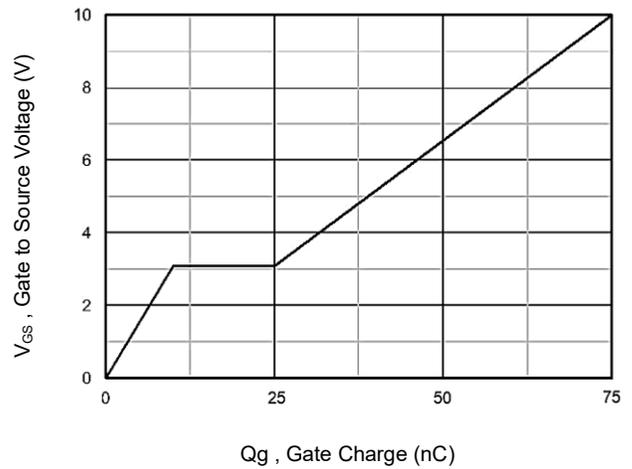
Transfer Characteristics



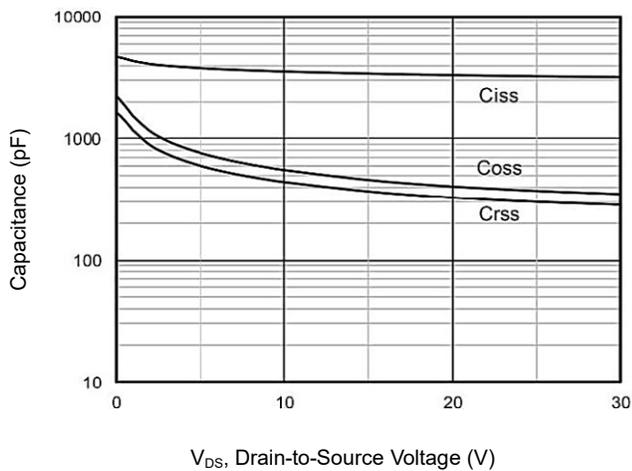
Gate Threshold Voltage vs Temperature



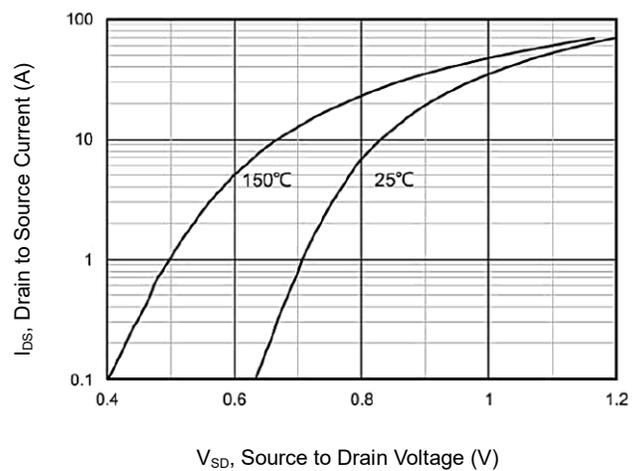
Gate Charge Waveform



Capacitance vs. Drain-Source Voltage

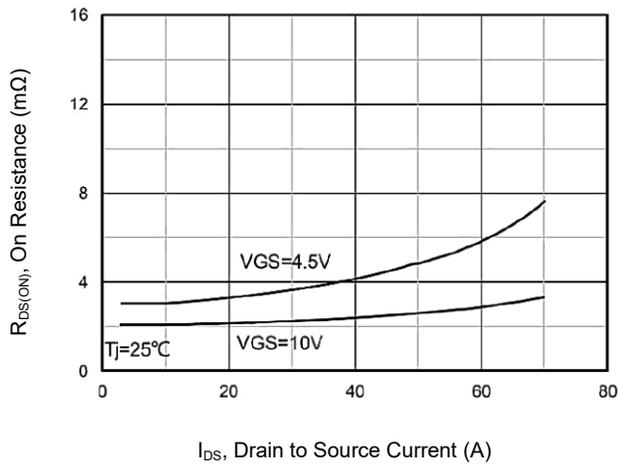


Body Diode Forward Voltage

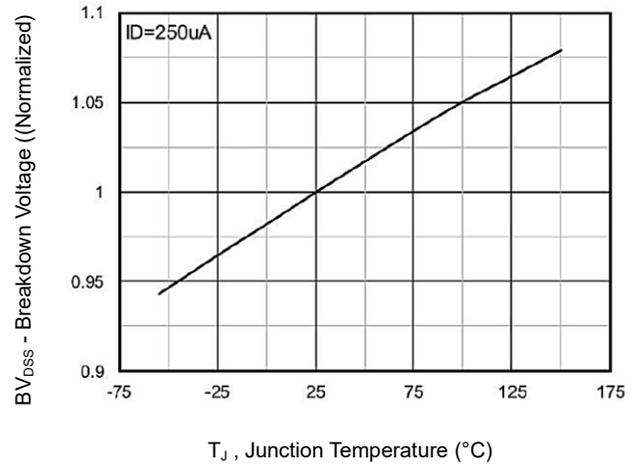


CHARACTERISTIC CURVES

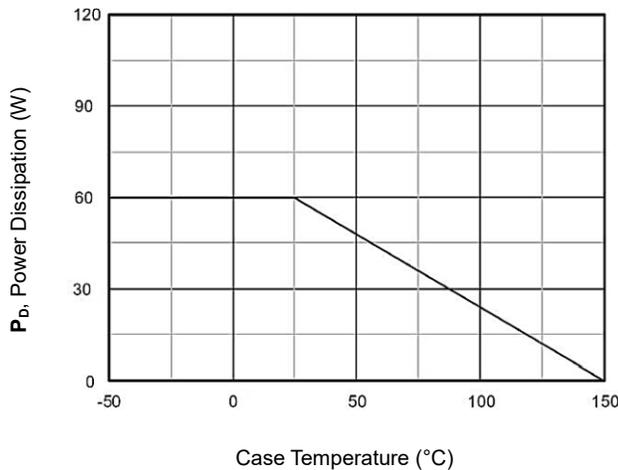
On-Resistance Variation with Drain Current



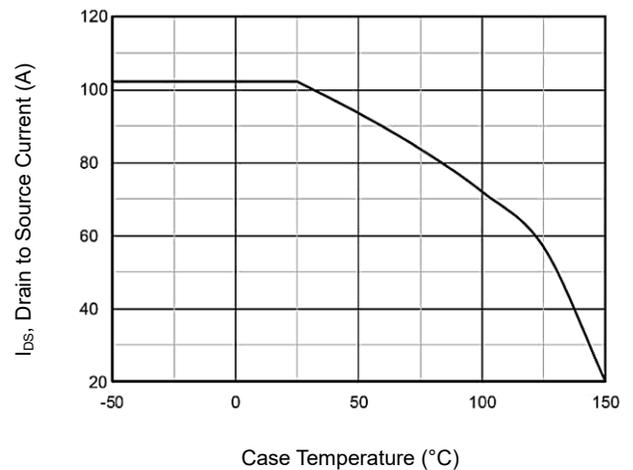
Breakdown Voltage vs Temperature



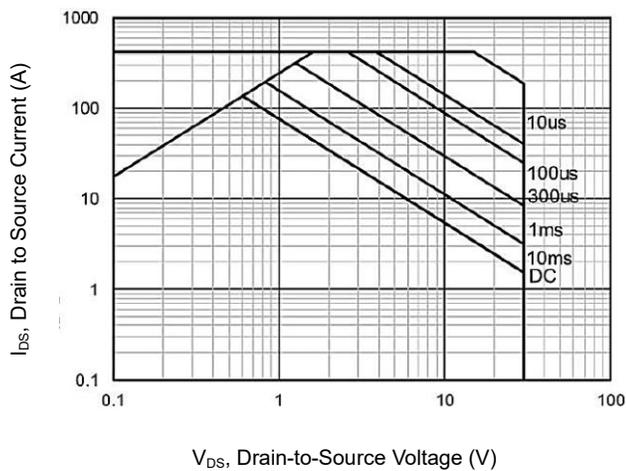
Power Dissipation



Current Dissipation



Maximum Safe Operating Area



Transient Thermal Impedance

